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Supplementary Information

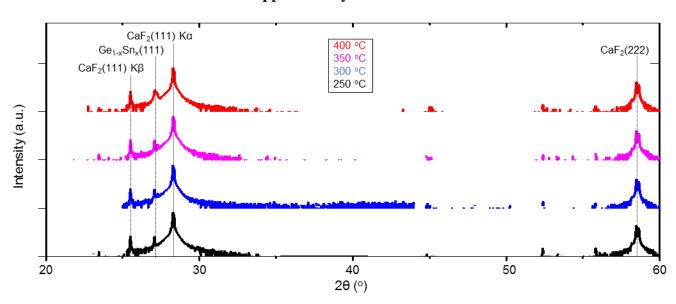


Figure S1. XRD $\theta/2\theta$ scans of $Ge_{1-x}Sn_x$ films grown on $CaF_2(111)$ substrates. Scans are plotted in log scale.

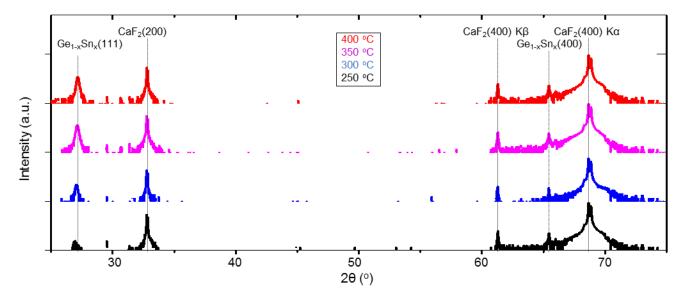


Figure S2. XRD $\theta/2\theta$ scans of $Ge_{1-x}Sn_x$ films grown on $CaF_2(100)$ substrates. Scans are plotted in log scale.

Note: Scans are plotted in logarithmic scale – if zero counts are recorded at a given 2θ position, no signal will show up in log scale.